# Shivaji University, Kolhapur

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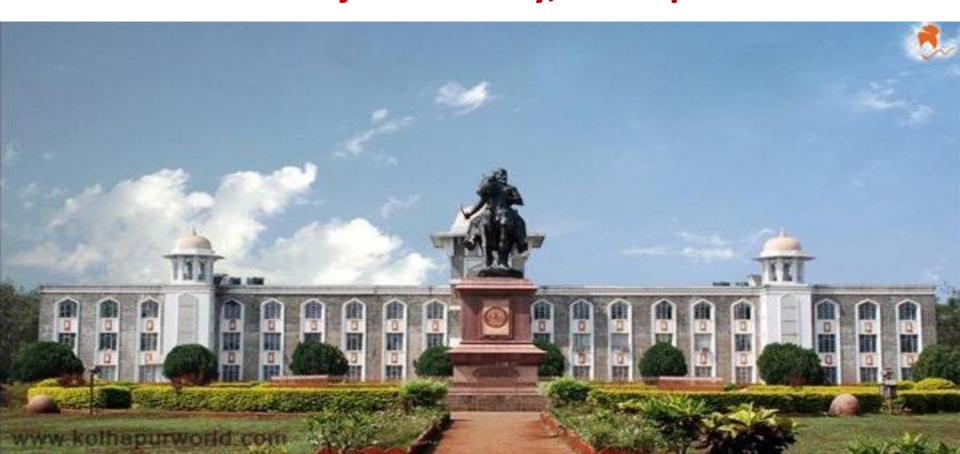
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# **Physics Instrumentation Facility Centre (PIFC)**

At

Department of Physics, Shivaji University, Kolhapur



#### Field Emission-Scanning Electron Microscope (FESEM)



Scheme: DST-FIST (2002-07)

**Cost: Rs. 1.70 Cr** 

Make: TESCAN Ltd., Czech Republic.

Model: MIRAJ 3

#### **Specifications:**

Specific Parameters	
System type	Fully Integrated PC
Resolution	2 nm at 10kV
Photo magnification	2X to 1,000,000X
Operating voltage	200 V to 30kV

**Application:** IRA3 offers faster image acquisition, an ultra-fast scanning system, dynamic and static compensation and built-in scripting for user-defined applications.

# Scanning Electron Microscope (SEM)



Scheme: DST-FIST (2002-07)

Cost: 47,72,825/- Rs

Make: Jeol Ltd., Japan.

Model: JSM 6360 A

#### **Specifications:**

Specific Parameters	
System type	Fully Integrated PC
Resolution	3 nm at 30kV
Photo magnification	30X to 1,00,000X
Operating voltage	500 V to 30kV

**Application:** SEM produces images of Powder, Thin films, thick films and pellets of materials.

# X-Ray Diffraction (XRD) (2)



Scheme: UGC-DSA I (2010-15)

Cost: 50, 00, 000/- Rs

Make: Bruker, Germany.

**Model: D2 Phaser** 

#### **Specifications:**

#### 5-35°C Operating temperature -3 to 160° Scanning range Cu (λ=1.54Å) Target

LYNXENE

 $0.005^{\circ}$ 

**Application:** The D2 PHASER is the most compact and fastest, all-in-one amorphous and crystalline phase analysis tool.

Detector

Min. Step Size

# Fourier transform Raman spectroscopy (FT-Raman)



Scheme: UGC-ASIST I (2005-10)

Cost: 52,00,000/- Rs

Make: Bruker, Germany.

**Model: Multi-RAM** 

#### **Specifications:**

Specific Parameters	
Spectral range	3600-36 cm <sup>-1</sup>
Wavelength	1064 nm
Resolution	0.5 cm <sup>-1</sup>
Detector	ND-YAG
Geometries	Both 180° & 90°

**Application:** The intuitive, easy-to-use OPUS software controls all data collection and manipulation functions for the Multi-RAM Stand Alone FT-Raman Spectrometer.

# **Electrochemical workstation: IMPS and IMVS**



Scheme: DST-FIST-II

Cost: 37,00,000/- Rs

Make: Metrohm, Switzerland

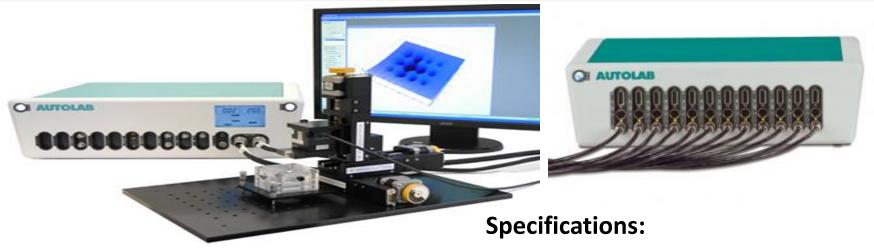
Model: Autolab 302N with 32 FRA

#### **Specifications:**

Specific Parameters	
Compliance voltage	±30 V
Resolution	20 μV
Current	± 10 nA-1A
Frequency	10μHz to 32 MHz

**Application:** In situ spectral measurement, Electrochemical characteristics

# Scanning Electrochemical Microscope (SECM)



**Scheme: DST-FIST-II** 

Cost: 35,00,000/- Rs

Make: Metrohm, Switzerland

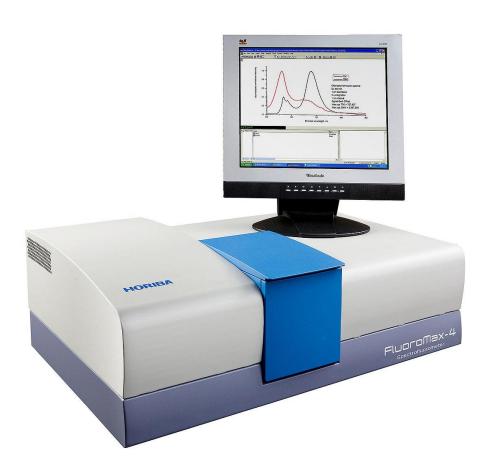
Model: Autolab 302N with 32 FRA

Sensolyte 0.045

Specific Parameters	
Compliance voltage	±30 V
Resolution	20 nm with CCD
Current	± 10 nA-1A
Frequency	10μHz to 32 MHz
Working area	3.5×2.5×2.5 cm

**Application:** Offers interface reaction, living cell imaging, surface patterning, electron transfer kinetics, electrocatalysis etc.

# Photoluminescence (PL)



Scheme: DST-PURSE (2010-13)

Cost: 26,35,000/- Rs

Make: Horiba Instuments, Japan.

**Model: Flouromax 4** 

#### **Specifications:**

Specific Parameters	
Excitation	Fully Integrated PC
Emission	3 nm at 30kV
Band pass	30X to 1,00,000X
Lifetime range	200 ps to 0.1 ms
Scan speed	80 nm/s

**Application:** offers the ultimate sensitivity in fluorescence investigations as well as features table-top fluorescence detection systems.

## **Atomic Force Microscope (AFM)**





Scheme: UGC-DSA I (2015-15)

Cost: 38,50,000/- Rs

Make: Bruker Instruments, Germany.

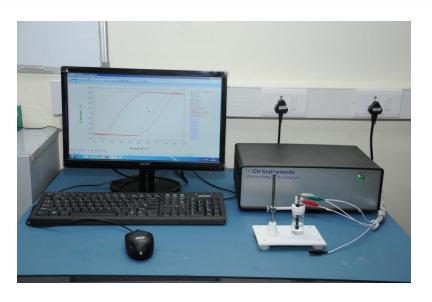
**Model: Innova 1B3BE** 

#### **Specifications:**

Specific Parameters	
Modes	Contact and Tapping
X-Y Scan rate	1-90 μm
Z Scan rate	50-7.5 μm

**Application:** Innova offers a unique, state-of-the-art closed-loop scan linearization system that ensures accurate measurements and noise levels approaching those of open-loop operation.

# Quartz crystal microbalance





**Scheme: DST-FIST (2002-07)** 

Cost: 10,00,000/- Rs

Make: CH Instruments, U.S.A.

Model: 400 B (Time resolved)

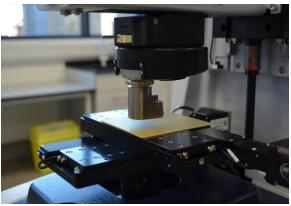
#### **Specifications:**

Specific Parameters	
Potential range	-10 to 10 V
Compliance voltage	± 12 V
Current resolution	0.01 pA
Current range	0-250 mA

**Application:** The quartz crystal microbalance (QCM) is a variant of acoustic wave microsensors that are capable of ultrasensitive mass measurement.

# **Surface profiler**





Scheme: DST-FIST (2002-07)

Cost: 15,36,243/- Rs

Make: Ambios technology, U.S.A.

Model: XP-1

#### **Specifications:**

Specific Parameters	
Vertical resolution	1.5 Å
Calibration	Laser
Lateral resolution	100 nm
Lateral length	200 nm

**Application:** The Surface profiler offers 2D topography of surface with 30mm scan length.

#### **Solar Simulator**



Scheme: DST-PURSE (2010-13)

Cost: 36,37,000/- Rs

Make: Photo emission tech., U.S.A.

**Model: CT 150 AAA** 

#### **Specifications:**

Specific Parameters	
Lamp power	1000 W
Illumination area	25×25 cm <sup>2</sup>
Air mass	AM0, AM1, AM 1.5
Intensity	100 W/ cm <sup>2</sup>

**Application:** The Surface profiler offers 2D topography of surface with 30mm scan length.

# **Electrochemical Impedance spectrometer (EIS)**



Scheme: DST-PURSE (2010-15)

Cost: 16,35,000/- Rs

Make: WonATech. S. Korea.

**Model: Zive SP5** 

#### **Specifications:**

Specific Parameters	
Frequency	10μHz to 1 MHz
Amplitude	1 mV to 1V
channels	Multi-channel
Current	2A to 20 pA

**Application:** Battery/ supercapacitor studies, electrochemical depostion and Impedance studies.

# Thermal conductivity



**Scheme: UGC-DRS (2000-05)** 

Cost: 4,00,000/- Rs

Make: Teleph Instruments, France.

Model: SA BP 113

#### **Specifications:**

Specific Parameters	
Range	Low temperature
Power	0.001-10 W/mK

Application: Specific heat and thermal conductivity of various materials.

#### **LCR** meter



**Scheme: UGC-DRS (2000-05)** 

Cost: 2,00,000/- Rs

Make: Hawlett Packard, .

Model: 4284 A

#### **Specifications:**

Specific Parameters	
Parameters	L, C, R, D, X θ
Impedance range	$0.1~\text{m}$ to $99~\text{M}\Omega$
Frequency	20 Hz to 1MHz

Application: Power measurement, capacitor, CV analysis and dielectric measurement.

# **Spray-CVD instrument**

**Scheme: UGC MRP 2015-2018** 

Project Cost: Rs. 14,20,000/-

Name of PI: Prof. P. S. Patil

**Make: Home Made** 

Cost of the instrument: Rs. 2,00,000/-

Specific Parameters	
Max Operating temperature	1100 °C
Hot Zone length	50 cm
Number of Steps per Program to control temp.	31

**Application:** To deposit thin films of Metal oxide, Metal chalcogenide and Transparent Conducting Oxide



### **Two Zone Furnace**

**Scheme: UGC MRP 2015-2018** 

Project Cost: Rs. 14,20,000/-

Name of PI: Prof. P. S. Patil

Make: Ants ceramics Pvt. Ltd.

Cost of the instrument: Rs. 1,70,000/-

Specific Parameters	
Max Operating temperature	1100 °C
Hot Zone length	15 cm each zone
Hot Zone diameter	4 cm
Number of Steps per Program to control temp.	31



**Application:** To sulfurize metal chalcogenide thin films, annealing in inert gas atmosphere and to synthesize CNT.

## **UV-VIS-NIR Spectrophotometer**



Scheme: UGC 2015-2018

Name of PI: Prof. P. S. Patil

Make: Shimadzu Instruments, Japan.

Cost of the instrument: Rs. 7,00,000/-

#### **Specifications:**

Specific Parameters	
Wavelength	190-1100 nm
EM region	UV, VIS and NIR
Accuracy	0.1 nm
Bandwidth	1nm

**Application:** measures the absorbance or transmittance at a single wavelength or a multiple wavelengths..

# Surface area Analyzer using BET



Scheme: CSIR (2012 - 15)

Name of PI: Prof. P. S. Patil

**Make: Quantachrome** 

Cost of the instrument: 13,00,000/-

#### **Specifications:**

Specific Parameters	
Operating temperature	25 – 300 °C
Surface area range	0.01 m <sup>2</sup> /g
Pore size range:	0.35 to >500nm
Minimum pore volume:	(STP) 0.0001 cc/g

**Application:** Quantachrome Nova e1000 is the most compact used to measure surface area, average pore size, and pore volume, of all powder samples.

# Central Facility Centre (CFC), Shivaji University, Kolhapur

# **Thermal Analyzer (DSC TGA)**



Scheme: XI th Plan

Cost: 18,000,00/- Rs

Make: TA Instruments.

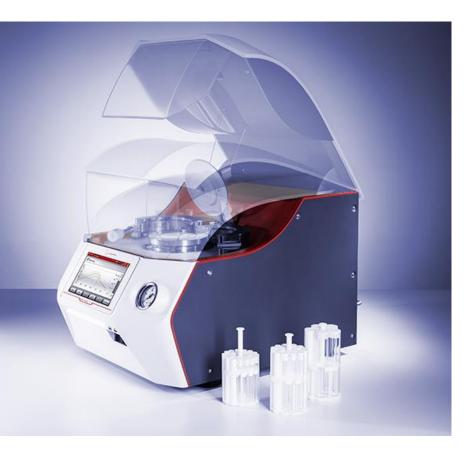
Model: SDT 650

Capacity

Specifications:	
Operating temperature	Up to 1500°C
Dynamic Temperature Precision	± 0.5°C
Heating Rate	0.1 to 100 °C/min
Sample Weight	200 mg

Application: To study the thermal decomposition rate of material.

# **Microwave Digestion System**



**Scheme: SAIF** 

Cost: 16,95,000/- Rs

**Make: Anton Paar** 

Specifications:	
Number of vials	18
Sample amounts (organic)	up to 1 g
Rec. filling volume	10 mL
Vial	Quartz, Glass

Application: used to dissolve heavy metals in the presence of organic molecules prior to analysis by inductively coupled plasma, atomic absorption, or atomic emission measurements.

# Particle size Analyzer with Zeta Potential



**Scheme: SAIF** 

Cost: 25,14,310/- Rs

Make: Malvern

**Model: Zetasizer Nano ZS90** 

Specifications:	
Size measurement	0.3nm to 5 microns
Molecular weight measurement	9,800Da – 20M Da
Source	He-Ne laser 633nm, Max 4mW
Temperature range extension option	Up to 120°C

Application: To measure the particle size, molecular size and molecular weight.

# Gas Chromatograph-Mass Spectrometer with Head Space sampler

**Scheme: SAIF** 

Cost: 1,18,22,419/- Rs

Make: Shimadzu

Model: GCMS-TQ8050

**HS-20** 



#### **Specifications:**

Headspace vials	10-mL and 20-mL
Maximum equilibration	300 °C
temperature	

Application: analysis and detection even of tiny amounts of a substance.

# Inductively Coupled Plasma Optical Emission Spectrometry (ICP-OES)



**Scheme: SAIF** 

Cost: 39,10,684/- Rs

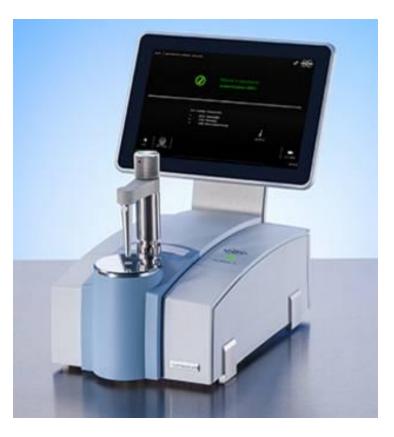
**Make: Agilent** 

**Model: 5110** 

Specifications:	
wavelength range	167 to 785 nm
Image Mapping	VistaChip II CCD detector
Sample to Sample time	22 to 52 sec
Control	Through ICP Expert software

Application: To determine concentration of the trace element within the sample.

# **FTIR Spectrometer**



Scheme: XII th Plan

Cost: 10,03,466/- Rs

Make: Bruker

**Model: ALPHA** 

Specifications:	
Sampling module	2x3" standard sample holder
Infrared source	Diode Laser
Spectral range	500 – 6,000 cm <sup>-1</sup>
Wavenumber accuracy	<0.05 cm <sup>-1</sup> @ 2000 cm <sup>-1</sup>
Detector	High sensitivity DLATGS

Application: To verify the identity and specifications of raw materials and products.

# **Gas Chromatograph-Mass Spectrometer**



Scheme: X th Plan

Cost: 25,07,105/- Rs

Make: Shimadzu

**Model: GCMS-QP2010** 

Specifications:	
Oven temperature	Up to 450°C
Injector port temp	Up to 450°C
AFC pressure range	0 to 970 kPa
Detector	Secondary electron multiplier with overdrive lens and conversion dynode
High-speed scan rate	20,000 u/sec

Application: To verify the identity and specifications of raw materials and products.

# **Transmission electron microscope (TEM)**



Application: To study material morphology with fine detail.

# X-ray photoelectron spectrometer(XPS)



Application: To measure the elemental composition, empirical formula, chemical state and electronic state of the elements that exist within a material.

# Micro Raman spectrometer



Application: To observe vibrational, rotational, and other low-frequency modes in a system.

# **Bio-AFM**



Application: To measure the mechanical properties of living material.

# Ultracentrifuge



Application: used in analysis of biological samples.

# **Vector Network Analyzer**



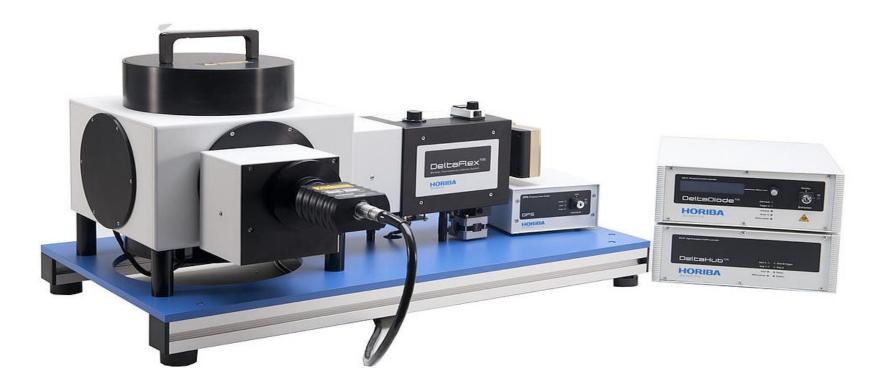
Application: To measure the network parameters of electrical networks.

# **Small Angle X-ray Scattering System (SAXS)**



Application: To determine nanoparticle size distributions, resolve the size and shape of (monodisperse) macromolecules, determine pore sizes, characteristic distances of partially ordered materials.

# Sophisticated Instrumentation Facility at Chemistry Department



Time resolved photoluminescence spectroscopy, (HORIBA)

- ✓ Interfacial charge carrier recombination rate
- ✓ Life time measurement



BET analysis, Nova, 1000e Quanta Chrome

✓ To determine the surface area



DLS, Particle Size analyzer, Nanoplus

- ✓ Electrostatic repulsion and effective surface charge
- ✓ Zeta potential



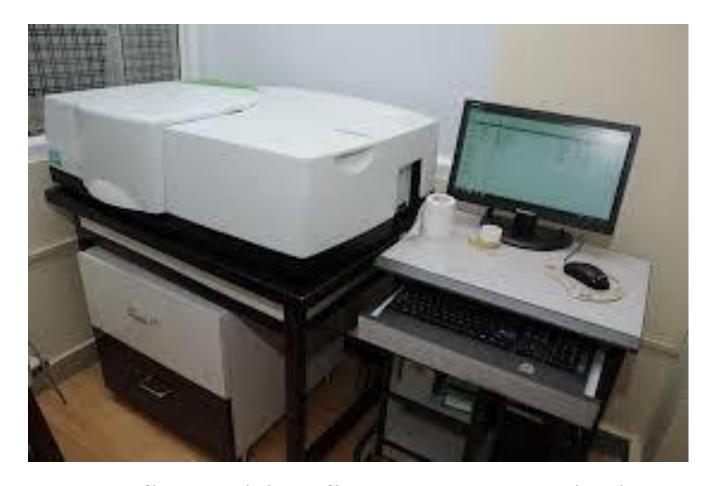
FTIR, Perkin Elmer

- ✓ Structural elucidation
- ✓ Functional group determination



NMR, Bruker 75 MHz

- ✓ To determine the structure of organic molecules in solution
- ✓ In advanced medical imaging technology



DRS-UV Visible Spectroscopy, Labindia

- ✓ Quantitative determination of different analytes
- ✓ In semiconductor industry to measure the thickness
- ✓ To measure the optical properties of thin films



LCMS shimadzu

- ✓ In pharmaceutical Industry
- ✓ In biomedical chemistry,



ICP-OES, Agilent 715

- ✓ Detection of trace metals in water, food, wine
- ✓ Widely used in minerals processing



Photoluminescence spectroscopy, FP-8300, JASCO

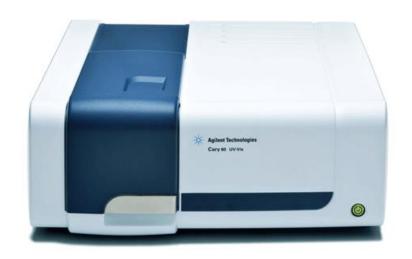
- ✓ detection of light emission patterns
- ✓ To study the optical properties of semiconductor

## **Research Facilities at SNST**

#### X-ray Powder Diffractometer (@ PIFC-SUK)



**UV-VIS Spectrophotometer** 





Surface Area Analyzer BET



**Parallel Synthesizer** 



**Spray Deposition Unit** 



Nano Fiber Electrospinning Unit





**Dip Coating Unit** 

**Spin Coating Unit** 

**Photoreactor** 



**SILAR Coating System** 









**PCR** 



**Laminar Air Flow** 





Refrigerated multipurpose centrifuge



**Shaking Incubator** 



**Shaking Water bath** 



**Gel Doc Unit** 



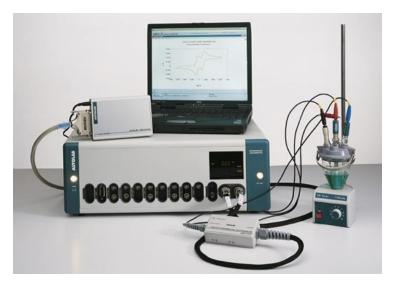
-86 Deep freezer



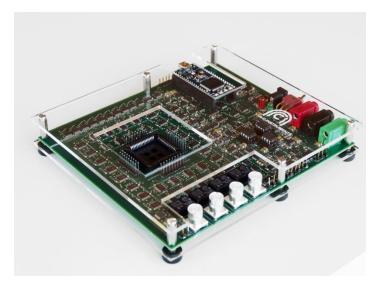
**Static Incubator** 



**Nano Drop** 



**Electrochemical Workstation** 



**Memristor Characterization System** 



**Automated Protein Purification System** 

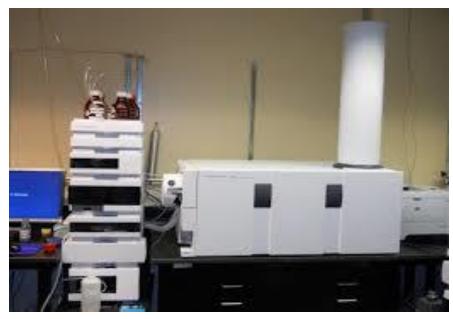


**Contact Angle Meter** 



Chemical Vapour Deposition

**Liquid Chromatography-Mass Spectrometry (LC MS-MS)** 



#### **Surface Plasmon Resonance**



Dept. of Biotechnology, SUK

